

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	4671	29/603.07,603.09,603.11,603.13-603.16,603.18,605,606,609.ccls.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:40
L2	7803	(read adj sensor) or (Spin adj valve)	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:40
L3	9054	(read adj sensor) or (Spin adj valve) or (MR adj sensor)	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:41
L4	2789	(first adj gap) same (second adj gap)	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:41
L5	141	3 and 4	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:42
L6	23	1 and 5	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:41
L7	326	((first or second) adj gap) same resistance	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:42
L8	16	6 and 7	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:42
L9	14	8 and @ad<"20010102"	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:45
L10	732	360/313,319,321-324.ccls.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:45
L11	44	7 and 10	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:45
L12	40	3 and 11	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:45
L13	34	12 and @ad<"20010102"	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:03
L14	2	("6678127").PN.	USPAT; USOCR; JPO; DERWENT	OR	OFF	2004/12/20 09:48

L15	14	("4164770"   "4983945"   "5508614"   "5587857"   "5761009"   "5771141"   "5805390"   "5818088"   "5903415"   "6034851"   "6222361"   "6246553"   "6288880"   "6424505").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2004/12/20 09:55
L16	4683	324/309-314,318,322,525,526,528.ccls.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:56
L17	2	3 and 16	USPAT; JPO; DERWENT	OR	ON	2004/12/20 09:56
L18	2	("3911899"   "4992737").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2004/12/20 09:57
L19	6	("5508614").URPN.	USPAT	OR	ON	2004/12/20 10:00
L20	215	451/127,128.ccls.	USPAT	OR	ON	2004/12/20 10:00
L21	2	3 and 20	USPAT	OR	ON	2004/12/20 10:00
L22	0	7 and 20	USPAT	OR	ON	2004/12/20 10:00
L23	3192	451/5,41.ccls.	USPAT	OR	ON	2004/12/20 10:00
L24	1	7 and 23	USPAT	OR	ON	2004/12/20 10:01
L25	56	Hsiao-richard.in.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:01
L26	0	jarrat-james-d.in.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:01
L27	1	klaassen-emo-hilbrand.in.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:02
L28	2	mcfadyen-ian-robson.in.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:02
L29	7	moran-timothy-j.in.	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:02
L30	62	25 or 27 or 28 or 29	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:03
L31	29	3 and 30	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:03
L32	20	31 and 7	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:03
L33	16	32 and @ad<"20010102"	USPAT; JPO; DERWENT	OR	ON	2004/12/20 10:03

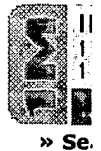
L34	1	3 and 4	JPO	OR	ON	2004/12/20 10:42
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(read sensor) &lt;and&gt; resistance

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**Results Key:****JNL** = Journal or Magazine   **CNF** = Conference   **STD** = Standard**1 Study of magnetic tunnel junction read sensors**
*Ho, M.K.; Tsang, C.H.; Fontana, R.E., Jr.; Parkin, S.S.; Carey, K.J.; Tao Pan; MacDonald, S.; Arnett, P.C.; Moore, J.O.;*

Magnetism, IEEE Transactions on , Volume: 37 , Issue: 4 , July 2001

Pages:1691 - 1694

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